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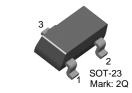


SEMICONDUCTOR®

2N5086/2N5087/MMBT5087

PNP General Purpose Amplifier

• This device is designed for low level, high gain, low noise general purpose amplifier applications at collector currents to 50mA.



2N5086/2N5087/MMBT5087

1. Emitter 2. Base 3. Collector 1. Base 2. Emitter 3. Collector

TO-92

Absolute Maximum Ratings* Ta=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	-50	V
V _{CBO}	Collector-Base Voltage	-50	V
V _{EBO}	Emitter-Base Voltage	-3.0	V
I _C	Collector current - Continuous	-100	mA
T _J , T _{sta}	Junction and Storage Temperature	-55 ~ +150	°C

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* These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

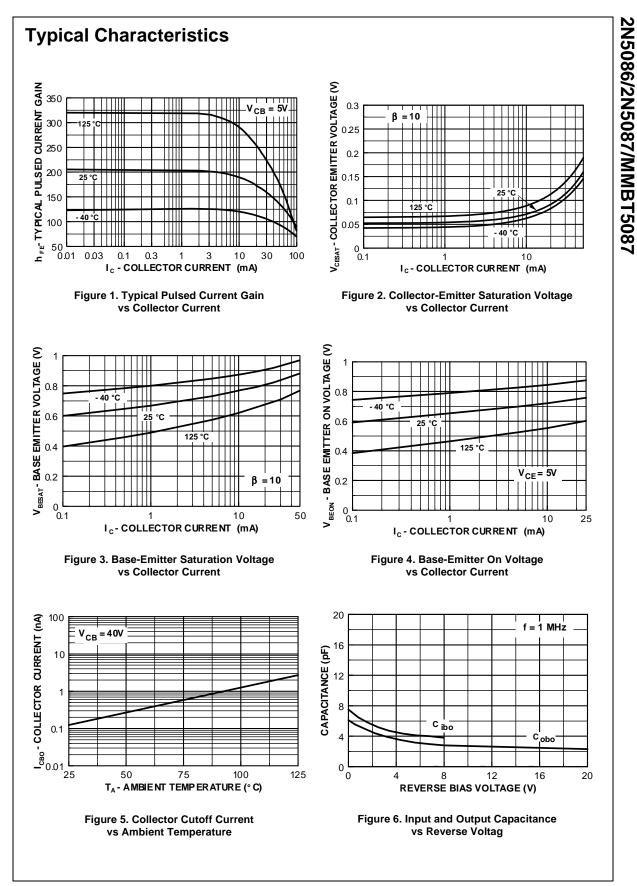
These ratings are based on a maximum junction temperature of 150 degrees C.
These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Electrical Characteristics Ta=25°C unless otherwise noted

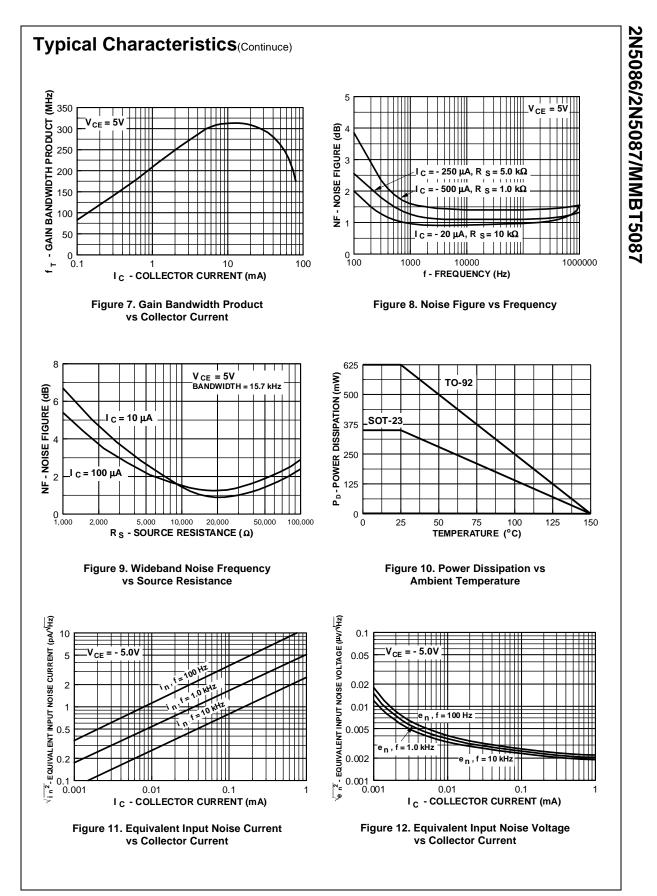
Symbol	Parameter	Test Condition		Min.	Max.	Units
Off Charac	teristics					
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage *	I _C = -1.0mA, I _B = 0		-50		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{\rm C} = -100 \mu {\rm A}, \ I_{\rm E} = 0$		-50		V
CEO	Collector Cutoff Current	$V_{CB} = -10V, I_E = 0$			-10	nA
		$V_{CB} = -35V, I_E = 0$			-50	nA
Сво	Emitter Cutoff Current	$V_{EB} = -3.0V, I_{C} = 0$			-50	nA
On Charac	teristics					
٦ _{FE}	DC Current Gain	$I_{C} = -100\mu A, V_{CE} = -5.0V$	5086	150	500	
			5087	250	800	
		$I_{C} = -1.0 \text{mA}, V_{CE} = -5.0 \text{V}$	5086	150		
			5087	250		
		$I_{C} = -10 \text{mA}, V_{CE} = -5.0 \text{V}$	5086	150		
			5087	250		
V _{CE(sat)}	Collector-Emitter Saturation Voltage	I _C = -10mA, I _B = -1.0mA			-0.3	V
V _{BE(on)}	Base-Emitter On Voltage	$I_{C} = -1.0 \text{mA}, V_{CE} = -5.0 \text{V}$			-0.85	V
	al Characteristics					
fT	Current Gain Bandwidth Product	$I_{C} = -500\mu A, V_{CE} = -5.0V, f = 20MHz$ 40			MHz	
C _{cb}	Collector-Base Capacitance	V _{CB} = -5.0V, I _E = 0, f = 100KHz			4.0	pF
h _{fe}	Small-Signal Current Gain	I _C = -1.0mA, V _{CE} = -5.0V,	5086	150	600	
		f = 1.0KHz	5087	250	900	
NF	Noise Figure	$I_{C} = -100\mu A, V_{CE} = -5.0V$	5086		3.0	dB
		$R_S = 3.0 k\Omega$, f = 1.0KHz	5087		2.0	dB
			5000			
		$I_{\rm C} = -20\mu A, V_{\rm CE} = -5.0V$	5086		3.0	dB
		$R_{\rm S} = 10 k\Omega$	5087		2.0	dB
	se Width ≤ 300μs, Duty Cycle ≤ 2.0%	f = 10Hz to 15.7KHz				

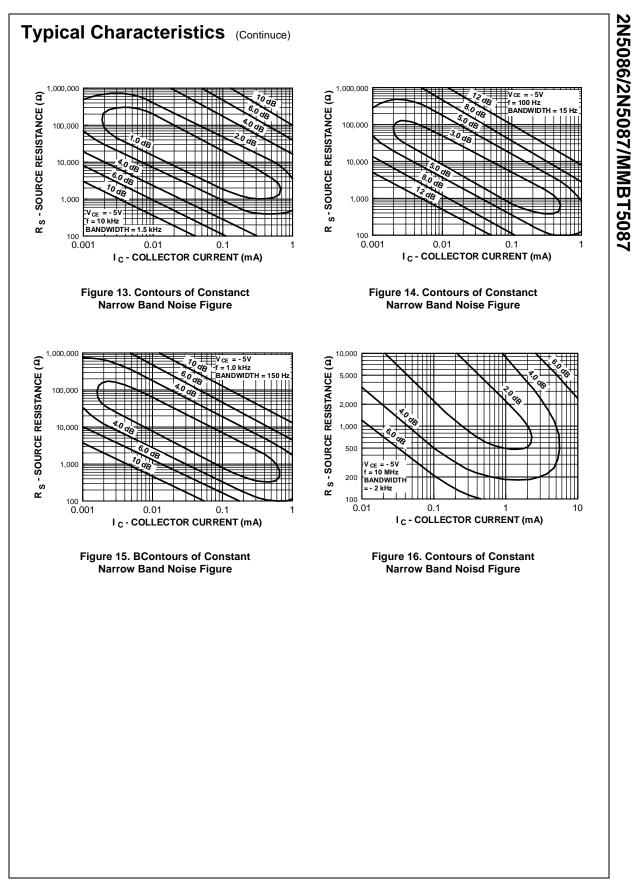
		N	Max.		
Symbol	Parameter	2N5086 2N5087	*MMBT5087	Units	
D	Total Device Dissipation	625	350	mW	
-	Derate above 25°C	5.0	2.8	mW/°C	
ς ^θ 1C	Thermal Resistance, Junction to Case	83.3		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	357	°C/W	

2N5086/2N5087/MMBT5087

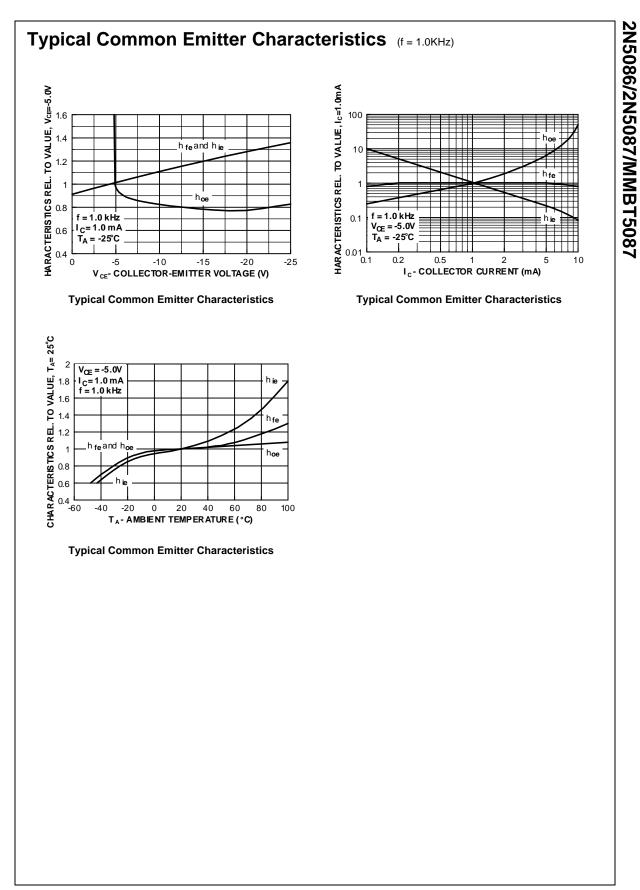


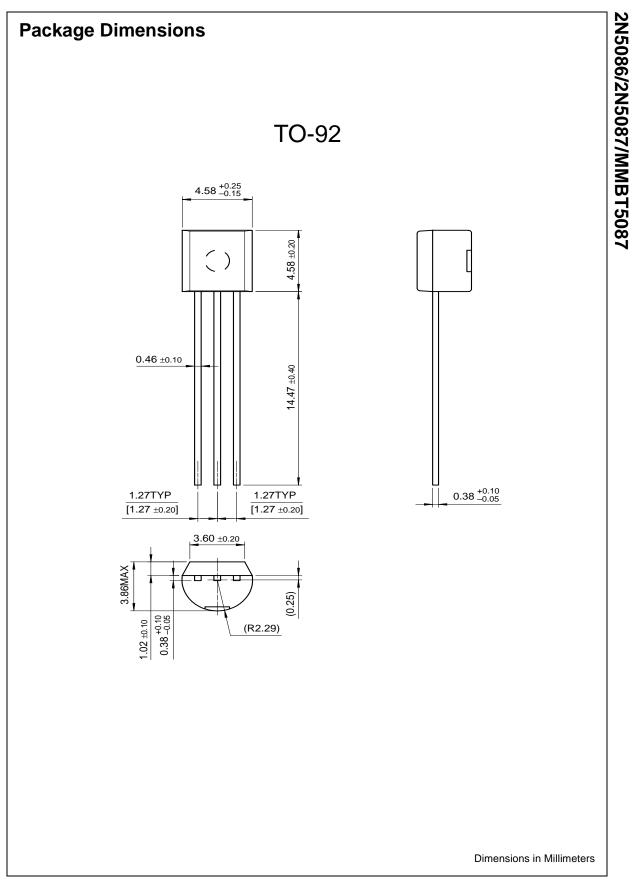
Rev. B1, September 2003

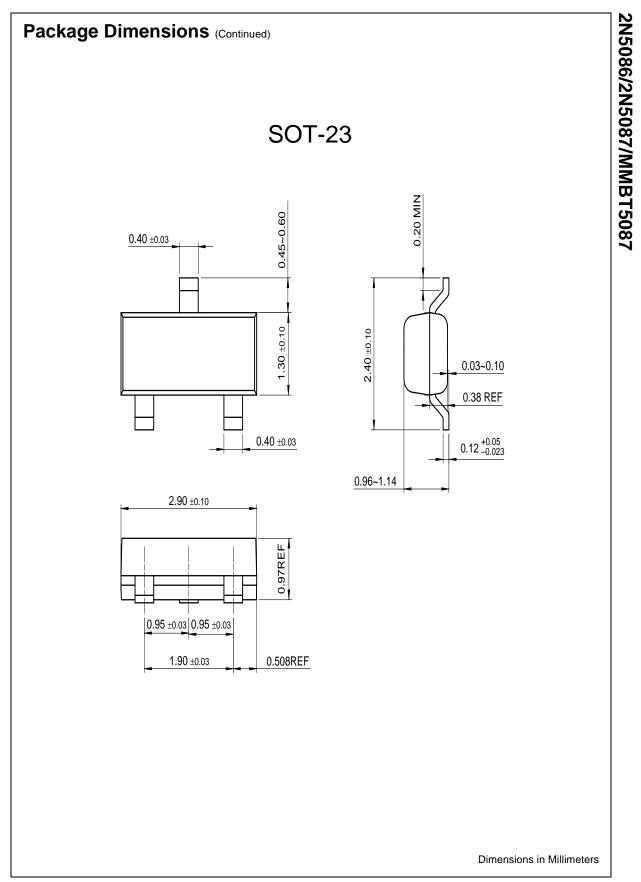




Rev. B1, September 2003







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The Power Franchise™		PACMAN™	Stealth™	
Programmable A	ctive Droop™	POP™	SuperSOT™-3	

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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